MOSFET - Single N-Channel 100 V, 9.0 mΩ, 60 A

NTBS9D0N10MC

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- Lowers Switching Noise/EMI
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- BMS/Storage, Home Automation

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Parameter		Symbol	Value	Unit	
Drain-to-Source Voltage		V _{DSS}	100	V	
Gate-to-Source Voltage		V _{GS}	±20	V	
Continuous Drain Current $R_{\theta JC}$ (Note 2)	Steady State	T _C = 25°C	۱ _D	60	A
Power Dissipation $R_{\theta JC}$ (Note 2)			P _D	68	W
Continuous Drain Current R _{θJA} (Notes 1, 2)	Steady State		Ι _D	14	A
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)			P _D	3.8	W
Pulsed Drain Current	$T_{C} = 25^{\circ}C, t_{p} = 100 \ \mu s$		I _{DM}	239	А
Operating Junction and Storage Temperature Range		T _J , T _{stg}	–55 to +175	°C	
Source Current (Body Diode)		IS	57	А	
Single Pulse Drain-to-Source Avalanche Energy ($I_L = 11 A_{pk}, L = 3 mH$)		E _{AS}	181.5	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using a 1 in², 2 oz. Cu pad.

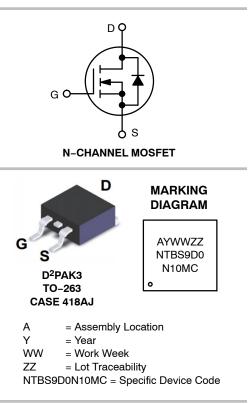
The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
100 V	9.0 mΩ @ 10 V	60 A



ORDERING INFORMATION

Device	Package	Shipping [†]
NTBS9D0N10MC	D ² PAK (Pb–Free)	800 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

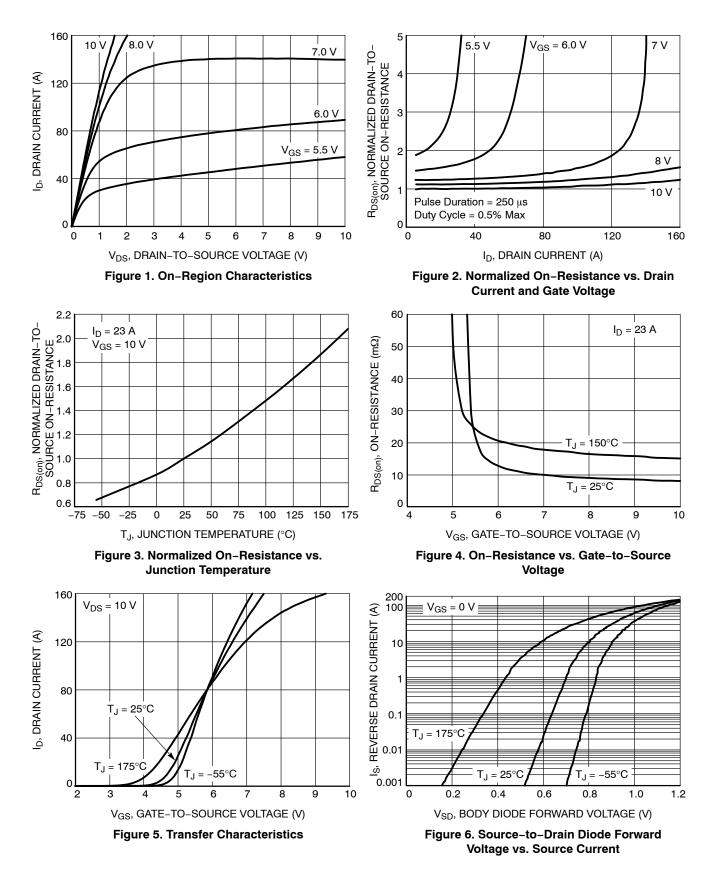
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ extsf{ heta}JC}$	2.2	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{ hetaJA}$	40	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

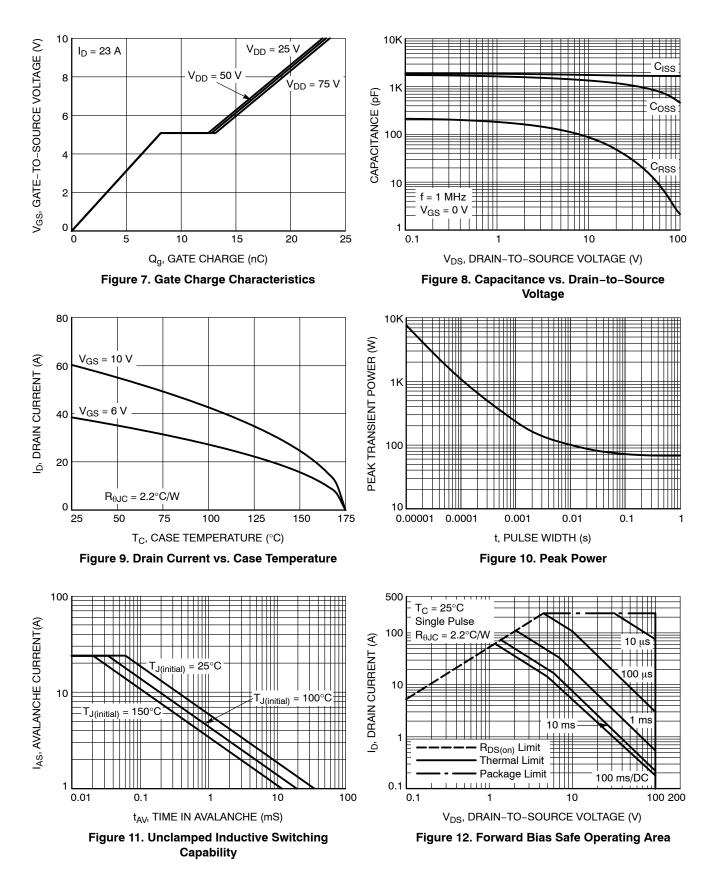
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 2	250 μΑ	100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	$I_D = 250 \ \mu A$, referenced to 25°C			56		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{CS} = 0 V_{c}$	$T_J = 25^{\circ}C$			1	μA
		$V_{GS} = 0 V, V_{DS} = 80 V T_{J} = 150$	T _J = 150°C			100	μA
Gate-to-Source Leakage Current	I _{GSS}	$V_{GS} = \pm 20$ V, V_{D}	_{os} = 0 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	131 μA	2.0	3.0	4.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	$I_D = 131 \ \mu$ A, referenced to 25°C			-9.6		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 23 A			7.8	9.0	mΩ
		V _{GS} = 6 V, I _D = 12 A			12	22.2	
Forward Transconductance	9 _{FS}	V _{DS} = 10 V, I _D = 23 A			59		S
Gate-Resistance	R _G	T _A = 25°C			0.6		Ω
CHARGES & CAPACITANCES						-	
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 50 V			1695		pF
Output Capacitance	C _{OSS}				935		
Reverse Transfer Capacitance	C _{RSS}				13		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 10 \text{ V}, V_{DS} = 50 \text{ V},$ $I_D = 23 \text{ A}$			23		nC
Threshold Gate Charge	Q _{G(TH)}				5		
Gate-to-Source Charge	Q _{GS}				8		
Gate-to-Drain Charge	Q _{GD}				5		
Output Charge	Q _{OSS}	V _{DS} = 50 V, V _{GS} = 0 V			59		
SWITCHING CHARACTERISTICS, VGS	= 10 V (Note 3)						
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 50 V, I _D = 23 A, R _G = 6 Ω			15		ns
Rise Time	tr				6		
Turn-Off Delay Time	t _{d(OFF)}				21		
Fall Time	t _f				7		
DRAIN-SOURCE DIODE CHARACTER	ISTICS					-	
Forward Diode Voltage	V _{SD}	V_{GS} = 0 V, I _S = 23 A, T _J = 25°C			0.87	1.2	V
		$V_{GS} = 0 \text{ V}, \text{ I}_{S} = 23 \text{ A}, \text{ T}_{J} = 150^{\circ}\text{C}$		0.72			
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dI _S /dt = 300 A/µs, I _S = 12 A			29		ns
Reverse Recovery Charge	Q _{RR}				61		nC
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, dI_S/dt = 1000 A/µs, I_S = 12 A			23		ns
Reverse Recovery Charge	Q _{RR}				147		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Switching characteristics are independent of operating junction temperature

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

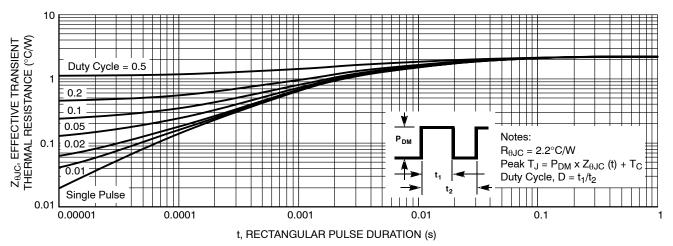
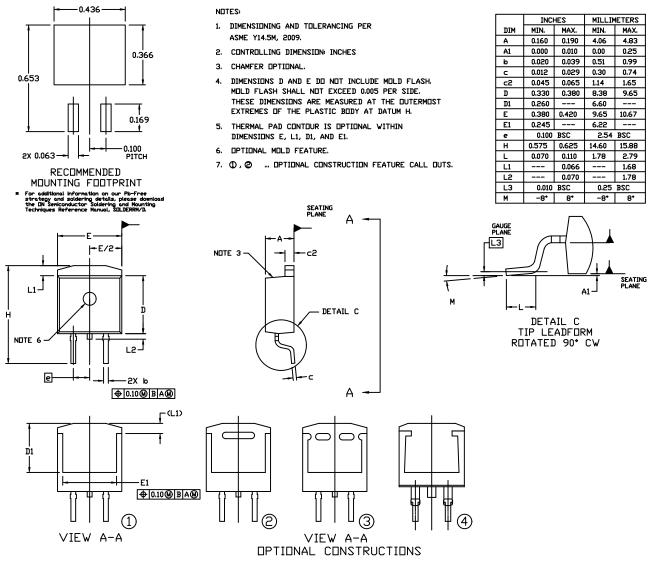


Figure 13. Transient Thermal Impedance

PACKAGE DIMENSIONS

D²PAK-3 (TO-263, 3-LEAD) CASE 418AJ

ISSUE E



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